Power MOSFET P-Channel ChipFET™

-3.9 Amps, -20 Volts

Features

- Low R_{DS(on)}
- Higher Efficiency Extending Battery Life
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package

Applications

• Power Management in Portable and Battery–Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Rating	Symbol	5 Secs	Steady State	Unit
Drain-Source Voltage	V _{DS}	-20		V
Gate-Source Voltage	V _{GS}	±12		V
Continuous Drain Current $(T_J = 150^{\circ}C)$ (Note 1) $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	Ι _D	±5.3 ±3.8	±3.9 ±2.8	А
Pulsed Drain Current	I _{DM}	±20		Α
Continuous Source Current (Note 1)	I _S	-2.1	-1.1	А
Maximum Power Dissipation (Note 1) T _A = 25°C T _A = 85°C	P _D	2.5 1.3	1.3 0.7	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150		°C

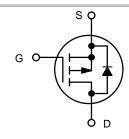
^{1.} Surface Mounted on 1" x 1" FR4 Board.



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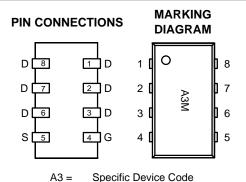
V _{(BR)DSS}	R _{DS(on)} TYP	I _D MAX	
-20 V	46 mΩ @ -4.5 V	-3.9 A	



P-Channel MOSFET



ChipFET CASE 1206A Style 1



M = Month Code

ORDERING INFORMATION

Device	Package	Shipping [†]		
NTHS5441T1	ChipFET	3000/Tape & Reel		

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
Maximum Junction–to–Ambient (Note 2) t ≤ 5 sec Steady State	R _{thJA}	40 80	50 95	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R _{thJF}	15	20	°C/W

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static	•	•	•	•	•	•
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-0.6	_	1.2	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	_	-	±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	-1.0	μΑ
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$	-	-	-5.0	
On-State Drain Current (Note 3)	I _{D(on)}	$V_{DS} \leq -5.0 \text{ V}, V_{GS} = -4.5 \text{ V}$	-20	-	_	Α
Drain-Source On-State Resistance (Note 3)	r _{DS(on)}	$V_{GS} = -3.6 \text{ V}, I_{D} = -3.7 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_{D} = -3.9 \text{ A}$	- -	0.050 0.046	0.06	Ω
		$V_{GS} = -2.5 \text{ V}, I_D = -3.1 \text{ A}$	_	0.070	0.083	
Forward Transconductance (Note 3)	9 _{fs}	$V_{DS} = -10 \text{ V}, I_{D} = -3.9 \text{ A}$	_	12	_	mhos
Diode Forward Voltage (Note 3)	V _{SD}	$I_S = -2.1 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.8	-1.2	V
Dynamic (Note 4)						
Total Gate Charge	Qg		-	9.7	22	nC
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V},$ $I_{D} = -3.9 \text{ A}$	-	1.2	_	
Gate-Drain Charge	Q _{gd}]	_	3.6	_	
Input Capacitance	C _{iss}		_	710	_	pF
Output Capacitance	C _{oss}	$V_{DS} = -5.0 \text{ Vdc}, V_{GS} = 0 \text{ Vdc},$ f = 1.0 MHz	-	400	_	
Reverse Transfer Capacitance	C _{rss}		-	140	_	
Turn-On Delay Time	t _{d(on)}		-	14	30	ns
Rise Time	t _r	$V_{DD} = -10 \text{ V}, R_L = 10 \Omega$	-	22	55	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1.0 \text{ A}, V_{GEN} = -4.5 \text{ V},$ $R_G = 6 \Omega$	_	42	100	1
Fall Time	t _f	1	_	35	70	
Source-Drain Reverse Recovery Time	t _{rr}	$I_F = -1.1 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$	_	30	60	1

Surface Mounted on 1" x 1" FR4 Board.
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

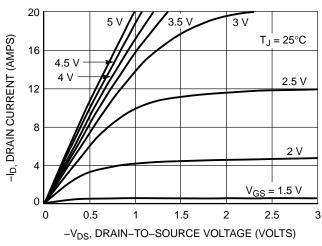


Figure 1. On-Region Characteristics

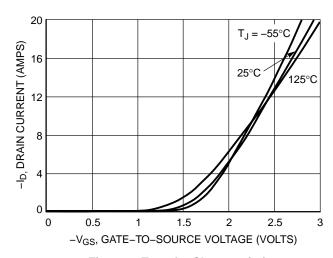


Figure 2. Transfer Characteristics

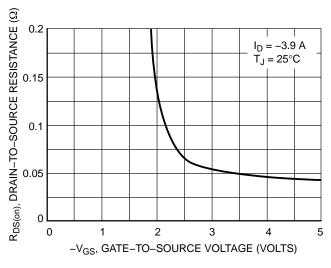


Figure 3. On–Resistance versus Gate–to–Source Voltage

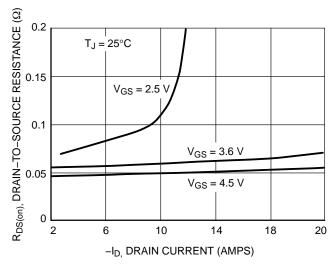


Figure 4. On–Resistance versus Drain Current and Gate Voltage

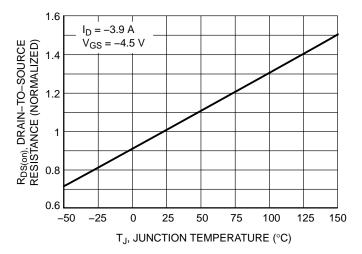


Figure 5. On–Resistance Variation with Temperature

TYPICAL ELECTRICAL CHARACTERISTICS

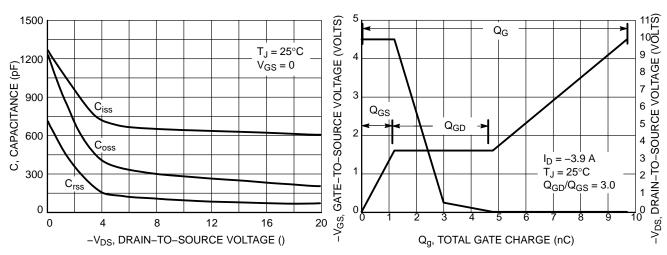


Figure 6. Capacitance Variation

Figure 7. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

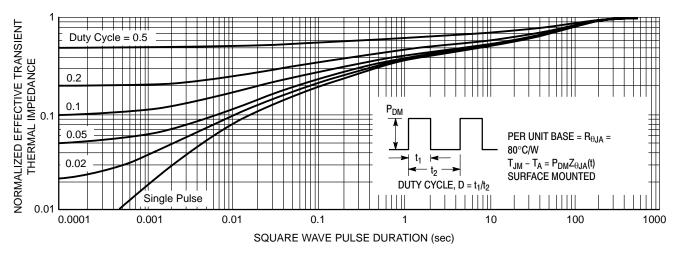


Figure 8. Normalized Thermal Transient Impedance, Junction-to-Ambient

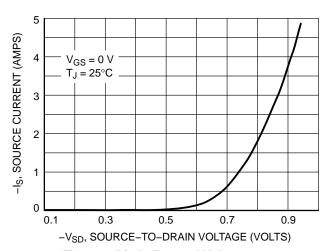
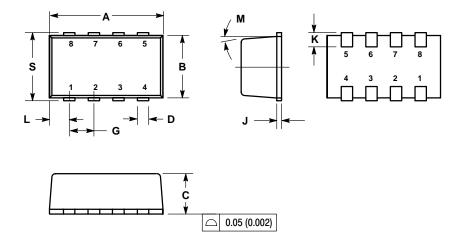


Figure 9. Diode Forward Voltage versus Current

PACKAGE DIMENSIONS

ChipFET™ CASE 1206A-03 **ISSUE E**



NOTES:

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: MILLIMETER.

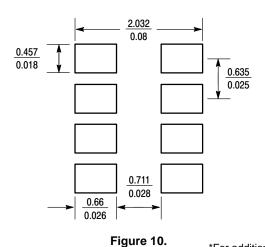
 3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.

 4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM. 0.08 MM.
- 5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE
- MINENSIONS A AND B EXCLUSIVE OF MOLD G. BURRS.
 NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INC	INCHES		
DIM	MIN	MAX	MIN	MAX		
Α	2.95	3.10	0.116	0.122		
В	1.55	1.70	0.061	0.067		
С	1.00	1.10	0.039	0.043		
D	0.25	0.35	0.010	0.014		
G	0.65 BSC		0.02	025 BSC		
J	0.10	0.20	0.004	0.008		
K	0.28	0.42	0.011	0.017		
L	0.55 BSC		0.02	22 BSC		
M	5° NOM		5 ° NOM			
S	1.80	2.00	0.072	0.080		

- STYLE 1:
 PIN 1. DRAIN
 2. DRAIN
 3. DRAIN
 4. GATE
 5. SOURCE
 6. DRAIN
 7. DRAIN
 8. DRAIN

SOLDER FOOTPRINTS*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

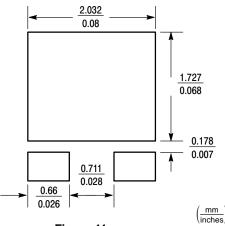


Figure 11.

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